Applicant(s)/Patent Under Application/Control No. Reexamination 09/806,462 KIGAWA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Teresa E Strzelecka 1637 **U.S. PATENT DOCUMENTS** Date Document Number Name Classification Country Code-Number-Kind Code MM-YYYY Sena et al. 435/6 US- 5, 670, 316 A 09-1997 Α US-В С US-US-D Ε US-F US-G US-US-Н US-1 J US-K US-US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY 03-1998 wo Kigawa et al. WO 98/08975 Ν EP 0 687 738 A1 12-1995 ΕP Kigawa et al. 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) υ W

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